

<b>Notice of References Cited</b>	Application/Control No. 10/791,410		Applicant(s)/Patent Under Reexamination SUN ET AL.	
	Examiner Timothy J. Henn		Art Unit 2622	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0223008	12-2003	Kim et al.	348/340
*	B	US-7,423,689	09-2008	Kim et al.	348/374
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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